Testing Services™	Appendix D for the BlackB SAR Report	Berry® Smartphone Mod	lel RDD71UW/RD0	C71UW	Page 1(36)
Author Data	Dates of Test	Test Report No	FCC ID:	IC ID	
Andrew Becker	Apr 13 – July 11, 2011	RTS-2579-1106-34A	L6ARDC70UW	2503A-R	DC70UW

APPENDIX D: PROBE & DIPOLE CALIBRATION DATA



Appendix D for the BlackBerry® Smartphone Model RDD71UW/RDC71UW **SAR Report**

2(36)

Author Data **Andrew Becker** Dates of Test Apr 13 – July 11, 2011 Test Report No RTS-2579-1106-34A FCC ID: L6ARDC70UW IC ID 2503A-RDC70UW

Calibration Laboratory of

Schmid & Partner Engineering AG Zeughausstrasse 43, 8004 Zurich, Switzerland





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The Swiss Accreditation Service is one of the signatories to the EA Multilateral Agreement for the recognition of calibration certificates

RTS (RIM Testing Services) Client

Accreditation No.: SCS 108

S

Certificate No: ES3-3225_Jan11

CALIBRATION CERTIFICATE

Object

ES3DV3 - SN:3225

Calibration procedure(s)

QA CAL-01.v7, QA CAL-23.v4 and QA CAL-25.v3 Calibration procedure for dosimetric E-field probes

Calibration date:

January 13, 2011

This calibration certificate documents the traceability to national standards, which realize the physical units of measurements (SI), The measurements and the uncertainties with confidence probability are given on the following pages and are part of the certificate.

All calibrations have been conducted in the closed laboratory facility: environment temperature (22 ± 3)°C and humidity < 70%,

Calibration Equipment used (M&TE critical for calibration)

Primary Standards	ID#	Cal Date (Certificate No.)	Scheduled Calibration
Power meter E4419B	GB41293874	1-Apr-10 (No. 217-01136)	Apr-11
Power sensor E4412A	MY41495277	1-Apr-10 (No. 217-01136)	Apr-11
Power sensor E4412A	MY41498087	1-Apr-10 (No. 217-01136)	Apr-11
Reference 3 dB Attenuator	SN: S5054 (3c)	30-Mar-10 (No. 217-01159)	Mar-11
Reference 20 dB Attenuator	SN: S5086 (20b)	30-Mar-10 (No. 217-01161)	Mar-11
Reference 30 dB Attenuator	SN: S5129 (30b)	30-Mar-10 (No. 217-01160)	Mar-11
Reference Probe ES3DV2	SN: 3013	29-Dec-10 (No. ES3-3013_Dec10)	Dec-11
DAE4	SN: 660	20-Apr-10 (No. DAE4-660_Apr10)	Apr-11
Secondary Standards	ID#	Check Date (in house)	Scheduled Check
RF generator HP 8648C	US3642U01700	4-Aug-99 (in house check Oct-09)	In house check: Oct-11
Network Analyzer HP 8753E	US37390585	18-Oct-01 (in house check Oct-10)	In house check: Oct-11
	Name	Function	Signature

Calibrated by:

Approved by:

Issued: January 15, 2011

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Certificate No: ES3-3225_Jan11

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Appendix D for the BlackBerry® Smartphone Model RDD71UW/RDC71UW **SAR Report**

3(36)

Author Data Andrew Becker Dates of Test Apr 13 – July 11, 2011

Test Report No RTS-2579-1106-34A FCC ID: L6ARDC70UW

IC ID 2503A-RDC70UW

Calibration Laboratory of Schmid & Partner





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Service suisse d'étalognage С Servizio svizzero di taratura Swiss Calibration Service

Accreditation No.: SCS 108

Engineering AG Zeughausstrasse 43, 8004 Zurich, Switzerland

Accredited by the Swiss Accreditation Service (SAS) The Swiss Accreditation Service is one of the signatories to the EA Multilateral Agreement for the recognition of calibration certificates

Glossary:

tissue simulating liquid TSL NORMx,y,z sensitivity in free space sensitivity in TSL / NORMx,y,z ConvF DCP diode compression point

CF crest factor (1/duty_cycle) of the RF signal A, B, C modulation dependent linearization parameters

Polarization o φ rotation around probe axis

Polarization 9 9 rotation around an axis that is in the plane normal to probe axis (at measurement center),

i.e., 9 = 0 is normal to probe axis

Calibration is Performed According to the Following Standards:

- a) IEEE Std 1528-2003, "IEEE Recommended Practice for Determining the Peak Spatial-Averaged Specific Absorption Rate (SAR) in the Human Head from Wireless Communications Devices: Measurement Techniques", December 2003
- b) IEC 62209-1, "Procedure to measure the Specific Absorption Rate (SAR) for hand-held devices used in close proximity to the ear (frequency range of 300 MHz to 3 GHz)", February 2005

Methods Applied and Interpretation of Parameters:

- NORMx, y, z: Assessed for E-field polarization 9 = 0 (f ≤ 900 MHz in TEM-cell; f > 1800 MHz: R22 waveguide). NORMx,y,z are only intermediate values, i.e., the uncertainties of NORMx,y,z does not effect the E2-field uncertainty inside TSL (see below ConvF).
- NORM(f)x, y, z = NORMx, y, z * frequency response (see Frequency Response Chart). This linearization is implemented in DASY4 software versions later than 4.2. The uncertainty of the frequency response is included in the stated uncertainty of ConvF.
- DCPx, v.z.: DCP are numerical linearization parameters assessed based on the data of power sweep with CW signal (no uncertainty required). DCP does not depend on frequency nor media.
- Ax,y,z; Bx,y,z; Cx,y,z, VRx,y,z; A, B, C are numerical linearization parameters assessed based on the data of power sweep for specific modulation signal. The parameters do not depend on frequency nor media. VR is the maximum calibration range expressed in RMS voltage across the diode.
- ConvF and Boundary Effect Parameters: Assessed in flat phantom using E-field (or Temperature Transfer Standard for f ≤ 800 MHz) and inside waveguide using analytical field distributions based on power measurements for f > 800 MHz. The same setups are used for assessment of the parameters applied for boundary compensation (alpha, depth) of which typical uncertainty values are given. These parameters are used in DASY4 software to improve probe accuracy close to the boundary. The sensitivity in TSL corresponds to NORMx,y,z * ConvF whereby the uncertainty corresponds to that given for ConvF. A frequency dependent ConvF is used in DASY version 4.4 and higher which allows extending the validity from ± 50 MHz to ± 100
- Spherical isotropy (3D deviation from isotropy): in a field of low gradients realized using a flat phantom exposed by a patch antenna.
- Sensor Offset: The sensor offset corresponds to the offset of virtual measurement center from the probe tip (on probe axis). No tolerance required.

Certificate No: ES3-3225_Jan11 Page 2 of 11

Testing Services™	Appendix D for the BlackB SAR Report	Berry® Smartphone Mod	lel RDD71UW/RD0	C71UW	Page 4(36)
Author Data	Dates of Test	Test Report No	FCC ID:	IC ID	
Andrew Becker	Apr 13 – July 11, 2011	RTS-2579-1106-34A	L6ARDC70UW	2503A-R	DC70UW

Probe ES3DV3

SN:3225

Manufactured: September 1, 2009 Last calibrated: December 11, 2009 Recalibrated: January 13, 2011

Calibrated for DASY/EASY Systems

(Note: non-compatible with DASY2 system!)



DASY/EASY - Parameters of Probe: ES3DV3 SN:3225

Basic Calibration Parameters

	Sensor X	Sensor Y	Sensor Z	Unc (k=2)
Norm (µV/(V/m) ²) ^A	1.26	1.21	1.31	± 10.1%
DCP (mV) ^B	102.1	100.8	99.1	

Modulation Calibration Parameters

UID	Communication System Name	PAR		A dB	B dBuV	С	VR mV	Unc ^E (k=2)
10000	cw	0.00	×	0.00	0.00	1.00	149.8	± 2.6 %
			Υ	0.00	0.00	1.00	148.1	
			Z	0.00	0.00	1.00	110.7	

The reported uncertainty of measurement is stated as the standard uncertainty of measurement multiplied by the coverage factor k=2, which for a normal distribution corresponds to a coverage probability of approximately 95%.

Certificate No: ES3-3225_Jan11

^a The uncertainties of NormX,Y,Z do not affect the E²-field uncertainty inside TSL (see Pages 5 and 6).

^b Numerical linearization parameter, uncertainty not required.

⁶ Uncertainty is determined using the maximum deviation from linear response applying recatangular distribution and is expressed for the square of the field value.

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Andrew Becker	Apr 13 – July 11, 2011	RTS-2579-1106-34A	L6ARDC70UW	2503A-R	DC70UW

ES3DV3 SN:3225

January 13, 2011

DASY/EASY - Parameters of Probe: ES3DV3 SN:3225

Calibration Parameter Determined in Head Tissue Simulating Media

f [MHz]	Validity [MHz] ^C	Permittivity	Conductivity	ConvF X Co	nvFY Cor	ıvF Z	Alpha	Depth Unc (k=2)
750	±50/±100	$41.9 \pm 5\%$	$0.89 \pm 5\%$	6.47	6.47	6.47	0.89	1.08 ± 11.0%
900	± 50 / ± 100	$41.5\pm5\%$	$0.97 \pm 5\%$	6.11	6.11	6.11	0.81	1.10 ± 11.0%
1810	± 50 / ± 100	40.0 ± 5%	$1.40 \pm 5\%$	5.26	5.26	5.26	0.37	1.68 ± 11.0%
1950	±50/±100	$40.0\pm5\%$	$1.40 \pm 5\%$	4.98	4.98	4.98	0.48	1.51 ± 11.0%
2450	± 50 / ± 100	39.2 ± 5%	$1.80 \pm 5\%$	4.60	4.60	4.60	0.52	1.54 ± 11.0%
2600	± 50 / ± 100	$39.0\pm5\%$	1.96 ± 5%	4.52	4.52	4.52	0.53	1.58 ± 11.0%

^c The validity of ± 100 MHz only applies for DASY v4.4 and higher (see Page 2). The uncertainty is the RSS of the ConvF uncertainty at calibration frequency and the uncertainty for the indicated frequency band.

Testing Services™	Appendix D for the BlackB SAR Report	Berry® Smartphone Mod	lel RDD71UW/RD0	C71UW	Page 7(36)
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Andrew Becker	Apr 13 – July 11, 2011	RTS-2579-1106-34A	L6ARDC70UW	2503A-R	DC70UW

ES3DV3 SN:3225

January 13, 2011

DASY/EASY - Parameters of Probe: ES3DV3 SN:3225

Calibration Parameter Determined in Body Tissue Simulating Media

f [MHz]	Validity [MHz] ^C	Permittivity	Conductivity	ConvF X Co	nvFY Co	nvF Z	Alpha	Depth Unc (k=2)
750	±50/±100	$55.5 \pm 5\%$	$0.96 \pm 5\%$	6.30	6.30	6.30	0.76	1.17 ± 11.0%
900	±50/±100	$55.0 \pm 5\%$	1.05 ± 5%	6.12	6.12	6.12	0.72	1.20 ± 11.0%
1810	±50/±100	53.3 ± 5%	1.52 ± 5%	4.88	4.88	4.88	0.26	2.70 ± 11.0%
1950	±50/±100	$53.3 \pm 5\%$	1.52 ± 5%	4.89	4.89	4.89	0.33	2.28 ± 11.0%
2450	± 50 / ± 100	52.7 ± 5%	$1.95 \pm 5\%$	4.43	4.43	4.43	0.99	1.04 ± 11.0%
2600	±50/±100	52.5 ± 5%	2.16 ± 5%	4.29	4.29	4.29	0.99	1.05 ± 11.0%

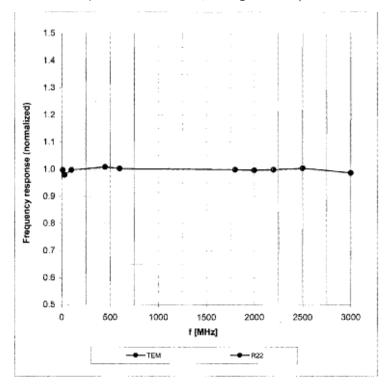
The validity of ± 100 MHz only applies for DASY v4.4 and higher (see Page 2). The uncertainty is the RSS of the ConvF uncertainty at calibration frequency and the uncertainty for the indicated frequency band.

Certificate No: ES3-3225_Jan11

Testing Services™	Appendix D for the Black SAR Report	Berry® Smartphone Mo	del RDD71UW/RD0	C 71UW	Page 8(36)
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Andrew Becker	Apr 13 – July 11, 2011	RTS-2579-1106-34A	L6ARDC70UW	2503A-R	DC70UW

Frequency Response of E-Field

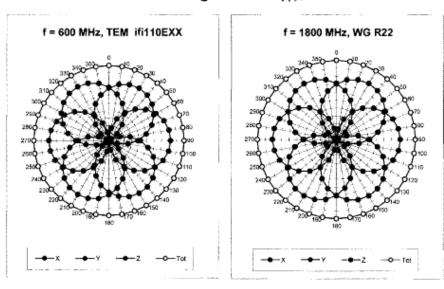
(TEM-Cell:ifi110 EXX, Waveguide: R22)

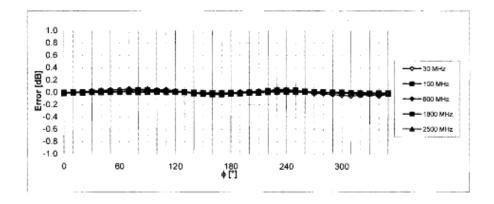


Uncertainty of Frequency Response of E-field: ± 6.3% (k=2)

Testing Services™	Appendix D for the BlackB SAR Report	Berry® Smartphone Mod	lel RDD71UW/RD0	C71UW	Page 9(36)
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Receiving Pattern (ϕ), ϑ = 0°



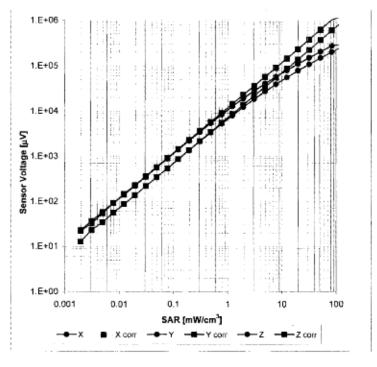


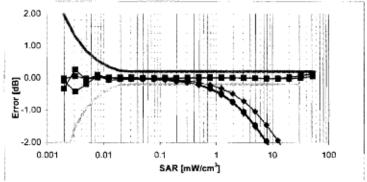
Uncertainty of Axial Isotropy Assessment: ± 0.5% (k=2)

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Andrew Becker	Apr 13 – July 11, 2011	RTS-2579-1106-34A	L6ARDC70UW	2503A-R	DC70UW

Dynamic Range f(SAR_{head})

(TEM cell, f = 900 MHz)

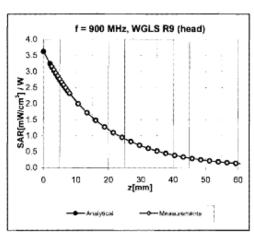


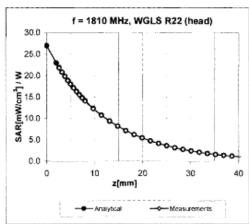


Uncertainty of Linearity Assessment: ± 0.6% (k=2)

Testing Services™	Appendix D for the BlackB SAR Report	serry® Smartphone Mod	lel RDD71UW/RD0	C71UW	Page 11(36)
Author Data	Dates of Test	Test Report No	FCC ID:	IC ID	
Andrew Becker	Apr 13 – July 11, 2011	RTS-2579-1106-34A	L6ARDC70UW	2503A-R	DC70UW

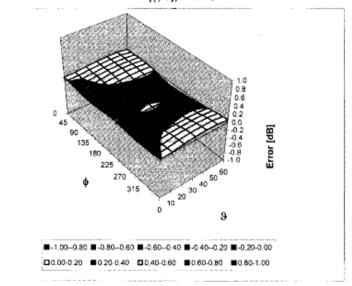
Conversion Factor Assessment





Deviation from Isotropy in HSL

Error (\(\phi, \(\partial \)), f = 900 MHz



Uncertainty of Spherical Isotropy Assessment: ± 2.6% (k=2)

Certificate No: ES3-3225_Jan11

Testing Services™	Appendix D for the BlackB SAR Report	Berry® Smartphone Mod	el RDD71UW/RDO	C71UW	Page 12(36)
Author Data	Dates of Test	Test Report No	FCC ID:	IC ID	
Andrew Becker	Apr 13 – July 11, 2011	RTS-2579-1106-34A	L6ARDC70UW	2503A-R	DC70UW

ES3DV3 SN:3225

January 13, 2011

Other Probe Parameters

Sensor Arrangement	Triangular
Connector Angle (°)	Not applicable
Mechanical Surface Detection Mode	enabled
Optical Surface Detection Mode	disabled
Probe Overall Length	337 mm
Probe Body Diameter	10 mm
Tip Length	10 mm
Tip Diameter	4 mm
Probe Tip to Sensor X Calibration Point	2 mm
Probe Tip to Sensor Y Calibration Point	2 mm
Probe Tip to Sensor Z Calibration Point	2 mm
Recommended Measurement Distance from Surface	3 mm



Document

Appendix D for the BlackBerry® Smartphone Model RDD71UW/RDC71UW SAR Report

13(36)

Author Data
Andrew Becker

Dates of Test

Apr 13 - July 11, 2011

Test Report No RTS-2579-1106-34A

FCC ID:

L6ARDC70UW

IC ID

2503A-RDC70UW

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Multilateral Agreement for the recognition of calibration certificates

Client RTS (RIM Testing Services)

Certificate No: D835V2-446_Jan11

Accreditation No.: SCS 108

CALIBRATION CERTIFICATE

Object D835V2 - SN: 446

Calibration procedure(s) QA CAL-05.v8

Calibration procedure for dipole validation kits

Calibration date: January 21, 2011

This calibration certificate documents the traceability to national standards, which realize the physical units of measurements (SI). The measurements and the uncertainties with confidence probability are given on the following pages and are part of the certificate.

All calibrations have been conducted in the closed laboratory facility: environment temperature (22 ± 3)°C and humidity < 70%.

Calibration Equipment used (M&TE critical for calibration)

Primary Standards	ID#	Cal Date (Certificate No.)	Scheduled Calibration
Power meter EPM-442A	GB37480704	06-Oct-10 (No. 217-01266)	Oct-11
Power sensor HP 8481A	US37292783	06-Oct-10 (No. 217-01266)	Oct-11
Reference 20 dB Attenuator	SN: 5086 (20g)	30-Mar-10 (No. 217-01158)	Mar-11
Type-N mismatch combination	SN: 5047.2 / 06327	30-Mar-10 (No. 217-01162)	Mar-11
Reference Probe ES3DV3	SN: 3205	30-Apr-10 (No. ES3-3205_Apr10)	Apr-11
DAE4	SN: 601	10-Jun-10 (No. DAE4-601_Jun10)	Jun-11
Secondary Standards	ID#	Check Date (in house)	Scheduled Check
Power sensor HP 8481A	MY41092317	18-Oct-02 (in house check Oct-09)	In house check: Oct-11
RF generator R&S SMT-06	100005	4-Aug-99 (in house check Oct-09)	In house check: Oct-11
Network Analyzer HP 8753E	US37390585 S4206	18-Oct-01 (in house check Oct-10)	In house check: Oct-11
	Name	Function	Signature
Calibrated by:	Dimce Illey	Laboratory Technician	D. Vill

Approved by:

Technical Manage

Issued: January 21, 2011

This calibration certificate shall not be reproduced except in full without written approval of the laboratory.

Certificate No: D835V2-446_Jan11

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Author Data

Andrew Becker

Appendix D for the BlackBerry® Smartphone Model RDD71UW/RDC71UW **SAR Report**

Dates of Test

Apr 13 – July 11, 2011

Test Report No RTS-2579-1106-34A FCC ID: L6ARDC70UW

IC ID 2503A-RDC70UW

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Calibration Laboratory of

Schmid & Partner Engineering AG Zeughausstrasse 43, 8004 Zurich, Switzerland





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Swiss Calibration Service

Accreditation No.: SCS 108

Accredited by the Swiss Accreditation Service (SAS)

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Glossarv:

TSL

tissue simulating liquid

ConvF N/A

sensitivity in TSL / NORM x,y,z not applicable or not measured

Calibration is Performed According to the Following Standards:

- a) IEEE Std 1528-2003, "IEEE Recommended Practice for Determining the Peak Spatial-Averaged Specific Absorption Rate (SAR) in the Human Head from Wireless Communications Devices: Measurement Techniques", December 2003
- b) IEC 62209-1, "Procedure to measure the Specific Absorption Rate (SAR) for hand-held devices used in close proximity to the ear (frequency range of 300 MHz to 3 GHz)",
- Federal Communications Commission Office of Engineering & Technology (FCC OET). "Evaluating Compliance with FCC Guidelines for Human Exposure to Radiofrequency Electromagnetic Fields; Additional Information for Evaluating Compliance of Mobile and Portable Devices with FCC Limits for Human Exposure to Radiofrequency Emissions", Supplement C (Edition 01-01) to Bulletin 65

Additional Documentation:

d) DASY4/5 System Handbook

Methods Applied and Interpretation of Parameters:

- Measurement Conditions: Further details are available from the Validation Report at the end of the certificate. All figures stated in the certificate are valid at the frequency indicated.
- Antenna Parameters with TSL: The dipole is mounted with the spacer to position its feed point exactly below the center marking of the flat phantom section, with the arms oriented parallel to the body axis.
- Feed Point Impedance and Return Loss: These parameters are measured with the dipole positioned under the liquid filled phantom. The impedance stated is transformed from the measurement at the SMA connector to the feed point. The Return Loss ensures low reflected power. No uncertainty required.
- Electrical Delay: One-way delay between the SMA connector and the antenna feed point. No uncertainty required.
- SAR measured: SAR measured at the stated antenna input power.
- SAR normalized: SAR as measured, normalized to an input power of 1 W at the antenna
- SAR for nominal TSL parameters: The measured TSL parameters are used to calculate the nominal SAR result.

Page 2 of 6 Certificate No: D835V2-446_Jan11

Testing Services™	Appendix D for the Black SAR Report	kBerry® Smartphone Mo	odel RDD71UW/RD	C71UW	Page 15(36)
Author Data	Dates of Test	Test Report No	FCC ID:	IC ID	
Andrew Becker	Apr 13 – July 11, 2011	RTS-2579-1106-34A	L6ARDC70UW	2503A-R	DC70UW

Measurement Conditions

DASY system configuration, as far as not given on page 1.

DASY Version	DASY5	V52.6
Extrapolation	Advanced Extrapolation	
Phantom	Modular Flat Phantom V4.9	
Distance Dipole Center - TSL	15 mm	with Spacer
Zoom Scan Resolution	dx, dy, dz = 5 mm	
Frequency	835 MHz ± 1 MHz	

Head TSL parameters

The following parameters and calculations were applied.

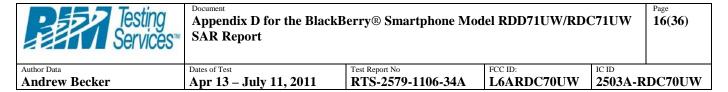
	Temperature	Permittivity	Conductivity
Nominal Head TSL parameters	22.0 °C	41.5	0.90 mho/m
Measured Head TSL parameters	(22.0 ± 0.2) °C	41.3 ± 6 %	0.89 mho/m ± 6 %
Head TSL temperature during test	(21.8 ± 0.2) °C		

SAR result with Head TSL

SAR averaged over 1 cm ³ (1 g) of Head TSL	Condition	
SAR measured	250 mW input power	2.39 mW / g
SAR normalized	normalized to 1W	9.56 mW / g
SAR for nominal Head TSL parameters	normalized to 1W	9.63 mW /g ± 17.0 % (k=2)

SAR averaged over 10 cm ³ (10 g) of Head TSL	condition	
SAR measured	250 mW input power	1.56 mW / g
SAR normalized	normalized to 1W	6.24 mW / g
SAR for nominal Head TSL parameters	normalized to 1W	6.27 mW /g ± 16.5 % (k=2)

Certificate No: D835V2-446_Jan11



Appendix

Antenna Parameters with Head TSL

Impedance, transformed to feed point	49.6 Ω - 7.7 jΩ
Return Loss	- 22.2 dB

General Antenna Parameters and Design

Electrical Delay (one direction)	1.386 ns

After long term use with 100W radiated power, only a slight warming of the dipole near the feedpoint can be measured.

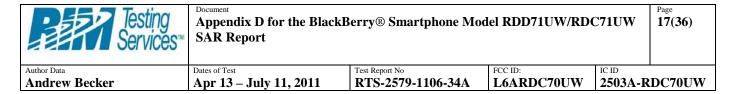
The dipole is made of standard semirigid coaxial cable. The center conductor of the feeding line is directly connected to the second arm of the dipole. The antenna is therefore short-circuited for DC-signals.

No excessive force must be applied to the dipole arms, because they might bend or the soldered connections near the feedpoint may be damaged.

Additional EUT Data

Manufactured by	SPEAG
Manufactured on	October 24, 2001

Certificate No: D835V2-446_Jan11



DASY5 Validation Report for Head TSL

Date/Time: 21.01.2011 10:18:05

Test Laboratory: SPEAG, Zurich, Switzerland

DUT: Dipole 835 MHz; Type: D835V2; Serial: D835V2 - SN:446

Communication System: CW; Frequency: 835 MHz; Duty Cycle: 1:1

Medium: HSL900

Medium parameters used: f = 835 MHz; $\sigma = 0.89 \text{ mho/m}$; $\epsilon_r = 41.2$; $\rho = 1000 \text{ kg/m}^3$

Phantom section: Flat Section

Measurement Standard: DASY5 (IEEE/IEC/ANSI C63.19-2007)

DASY5 Configuration:

Probe: ES3DV3 - SN3205; ConvF(6.03, 6.03, 6.03); Calibrated: 30.04.2010

Sensor-Surface: 3mm (Mechanical Surface Detection)

Electronics: DAE4 Sn601; Calibrated: 10.06.2010

Phantom: Flat Phantom 4.9L; Type: QD000P49AA; Serial: 1001

Measurement SW: DASY52, V52.6.1 Build (408)

Postprocessing SW: SEMCAD X, V14.4.2 Build (2595)

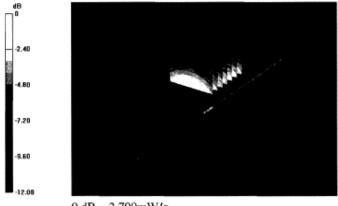
Pin=250 mW /d=15mm, dist=3.0mm (ES-Probe)/Zoom Scan (7x7x7) /Cube 0: Measurement

grid: dx=5mm, dy=5mm, dz=5mm

Reference Value = 57.426 V/m; Power Drift = 0.04 dB

Peak SAR (extrapolated) = 3.600 W/kg

SAR(1 g) = 2.39 mW/g; SAR(10 g) = 1.56 mW/gMaximum value of SAR (measured) = 2.790 mW/g



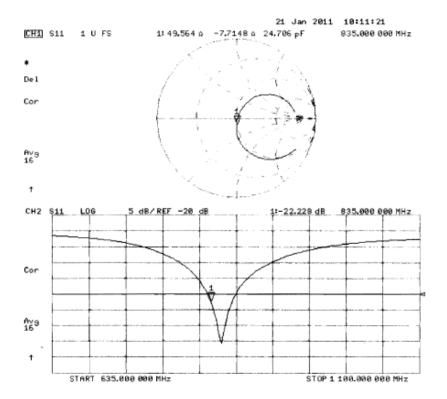
0 dB = 2.790 mW/g

Certificate No: D835V2-446_Jan11

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Author Data	Dates of Test	Test Report No	FCC ID:	IC ID	
Andrew Becker	Apr 13 – July 11, 2011	RTS-2579-1106-34A	L6ARDC70UW	2503A-R	DC70UW

Impedance Measurement Plot for Head TSL





Document

Appendix D for the BlackBerry® Smartphone Model RDD71UW/RDC71UW SAR Report

19(36)

Author Data
Andrew Becker

Dates of Test

Apr 13 – July 11, 2011

Test Report No RTS-2579-1106-34A

FCC ID: L6ARDC70UW

1C ID **2503A-RDC70UW**

Calibration Laboratory of Schmid & Partner Engineering AG Zeughausstrasse 43, 8004 Zurich, Switzerland





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Multilateral Agreement for the recognition of calibration certificates

Client RTS (RIM Testing Services)

Accreditation No.: SCS 108

Certificate No: D1800V2-2d020_Jan11

CALIBRATION CERTIFICATE Object D1800V2 - SN: 2d020 Calibration procedure(s) QA CAL-05.v8 Calibration procedure for dipole validation kits Calibration date: January 13, 2011

This calibration certificate documents the traceability to national standards, which realize the physical units of measurements (SI).

The measurements and the uncertainties with confidence probability are given on the following pages and are part of the certificate.

All calibrations have been conducted in the closed laboratory facility: environment temperature (22 ± 3)°C and humidity < 70%.

Calibration Equipment used (M&TE critical for calibration)

Primary Standards	ID#	Cal Date (Certificate No.)	Scheduled Calibration
Power meter EPM-442A	GB37480704	06-Oct-10 (No. 217-01266)	Oct-11
Power sensor HP 8481A	US37292783	06-Oct-10 (No. 217-01266)	Oct-11
Reference 20 dB Attenuator	SN: 5086 (20g)	30-Mar-10 (No. 217-01158)	Mar-11
Type-N mismatch combination	SN: 5047.2 / 06327	30-Mar-10 (No. 217-01162)	Mar-11
Reference Probe ES3DV3	SN: 3205	30-Apr-10 (No. ES3-3205_Apr10)	Apr-11
DAE4	SN: 601	10-Jun-10 (No. DAE4-601_Jun10)	Jun-11
Secondary Standards	ID#	Check Date (in house)	Scheduled Check
Power sensor HP 8481A	MY41092317	18-Oct-02 (in house check Oct-09)	In house check: Oct-11
RF generator R&S SMT-06	100005	4-Aug-99 (in house check Oct-09)	In house check: Oct-11
Network Analyzer HP 8753E	US37390585 S4206	18-Oct-01 (in house check Oct-10)	In house check: Oct-11
	Name	Function	Signature
Calibrated by:	Dimce lilev	Laboratory Technician	D'Riler
Approved by:	Katja Pokovic	Technical Manager	ICKS
			Issued: January 13, 2011

Certificate No: D1800V2-2d020_Jan11

Page 1 of 6



Document

$\label{lem:second-equation} \textbf{Appendix D for the BlackBerry} \& \textbf{Smartphone Model RDD71UW/RDC71UW} \\ \textbf{SAR Report}$

Page **20(36)**

Author Data
Andrew Becker

Dates of Test **Apr 13 – July 11, 2011**

Test Report No RTS-2579-1106-34A

FCC ID: L6ARDC70UW

1C ID **2503A-RDC70UW**

Calibration Laboratory of

Schmid & Partner Engineering AG Zeughausstrasse 43, 8004 Zurich, Switzerland





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S Swiss Calibration Service

Accreditation No.: SCS 108

Accredited by the Swiss Accreditation Service (SAS)

The Swiss Accreditation Service is one of the signatories to the EA Multilateral Agreement for the recognition of calibration certificates

Glossary:

TSL tissue simulating liquid

ConvF sensitivity in TSL / NORM x,y,z N/A not applicable or not measured

Calibration is Performed According to the Following Standards:

- a) IEEE Std 1528-2003, "IEEE Recommended Practice for Determining the Peak Spatial-Averaged Specific Absorption Rate (SAR) in the Human Head from Wireless Communications Devices: Measurement Techniques", December 2003
- b) IEC 62209-1, "Procedure to measure the Specific Absorption Rate (SAR) for hand-held devices used in close proximity to the ear (frequency range of 300 MHz to 3 GHz)", February 2005
- c) Federal Communications Commission Office of Engineering & Technology (FCC OET), "Evaluating Compliance with FCC Guidelines for Human Exposure to Radiofrequency Electromagnetic Fields; Additional Information for Evaluating Compliance of Mobile and Portable Devices with FCC Limits for Human Exposure to Radiofrequency Emissions", Supplement C (Edition 01-01) to Bulletin 65

Additional Documentation:

d) DASY4/5 System Handbook

Methods Applied and Interpretation of Parameters:

- Measurement Conditions: Further details are available from the Validation Report at the end
 of the certificate. All figures stated in the certificate are valid at the frequency indicated.
- Antenna Parameters with TSL: The dipole is mounted with the spacer to position its feed
 point exactly below the center marking of the flat phantom section, with the arms oriented
 parallel to the body axis.
- Feed Point Impedance and Return Loss: These parameters are measured with the dipole
 positioned under the liquid filled phantom. The impedance stated is transformed from the
 measurement at the SMA connector to the feed point. The Return Loss ensures low
 reflected power. No uncertainty required.
- Electrical Delay: One-way delay between the SMA connector and the antenna feed point.
 No uncertainty required.
- SAR measured: SAR measured at the stated antenna input power.
- SAR normalized: SAR as measured, normalized to an input power of 1 W at the antenna connector.
- SAR for nominal TSL parameters: The measured TSL parameters are used to calculate the nominal SAR result.

Certificate No: D1800V2-2d020_Jan11

Page 2 of 6



Measurement Conditions

DASY system configuration, as far as not given on page 1.

DASY Version	DASY5	V52.6
Extrapolation	Advanced Extrapolation	
Phantom	Modular Flat Phantom V5.0	
Distance Dipole Center - TSL	10 mm	with Spacer
Zoom Scan Resolution	dx, dy, dz = 5 mm	
Frequency	1800 MHz ± 1 MHz	

Head TSL parameters

The following parameters and calculations were applied.

	Temperature	Permittivity	Conductivity
Nominal Head TSL parameters	22.0 °C	40.0	1.40 mho/m
Measured Head TSL parameters	(22.0 ± 0.2) °C	38.6 ± 6 %	1.38 mho/m ± 6 %
Head TSL temperature during test	(21.3 ± 0.2) °C		****

SAR result with Head TSL

SAR averaged over 1 cm ³ (1 g) of Head TSL	Condition	
SAR measured	250 mW input power	9.78 mW / g
SAR normalized	normalized to 1W	39.1 mW / g
SAR for nominal Head TSL parameters	normalized to 1W	39.2 mW /g ± 17.0 % (k=2)

SAR averaged over 10 cm ³ (10 g) of Head TSL	condition	
SAR measured	250 mW input power	5.13 mW / g
SAR normalized	normalized to 1W	20.5 mW / g
SAR for nominal Head TSL parameters	normalized to 1W	20.5 mW /g ± 16.5 % (k=2)

Certificate No: D1800V2-2d020_Jan11



Appendix

Antenna Parameters with Head TSL

Impedance, transformed to feed point	46.5 Ω - 7.3 jΩ
Return Loss	- 21.5 dB

General Antenna Parameters and Design

Electrical Delay (one direction)	1.216 ns

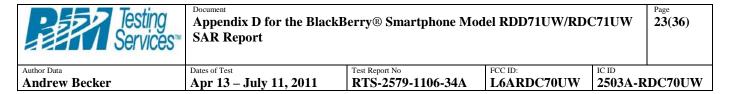
After long term use with 100W radiated power, only a slight warming of the dipole near the feedpoint can be measured.

The dipole is made of standard semirigid coaxial cable. The center conductor of the feeding line is directly connected to the second arm of the dipole. The antenna is therefore short-circuited for DC-signals.

No excessive force must be applied to the dipole arms, because they might bend or the soldered connections near the feedpoint may be damaged.

Additional EUT Data

Manufactured by	SPEAG	
Manufactured on	September 07, 2001	



DASY5 Validation Report for Head TSL

Date/Time: 13.01.2011 12:34:12

Test Laboratory: SPEAG, Zurich, Switzerland

DUT: Dipole 1800 MHz; Type: D1800V2; Serial: D1800V2 - SN:2d020

Communication System: CW; Frequency: 1800 MHz; Duty Cycle: 1:1

Medium: HSL U12 BB

Medium parameters used: f = 1800 MHz; $\sigma = 1.38 \text{ mho/m}$; $\varepsilon_r = 38.7$; $\rho = 1000 \text{ kg/m}^3$

Phantom section: Flat Section

Measurement Standard: DASY5 (IEEE/IEC/ANSI C63.19-2007)

DASY5 Configuration:

Probe: ES3DV3 - SN3205; ConvF(5.05, 5.05, 5.05); Calibrated: 30.04.2010

Sensor-Surface: 3mm (Mechanical Surface Detection)

Electronics: DAE4 Sn601; Calibrated: 10.06.2010

Phantom: Flat Phantom 5.0 (front); Type: QD000P50AA; Serial: 1001

Measurement SW: DASY52, V52.6.1 Build (408)

Postprocessing SW: SEMCAD X, V14.4.2 Build (2595)

Pin=250 mW /d=10mm, dist=3.0mm (ES-Probe)/Zoom Scan (7x7x7) /Cube 0: Measurement

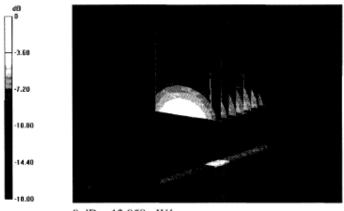
grid: dx=5mm, dy=5mm, dz=5mm

Reference Value = 96.654 V/m; Power Drift = 0.04 dB

Peak SAR (extrapolated) = 17.902 W/kg

SAR(1 g) = 9.78 mW/g; SAR(10 g) = 5.13 mW/g

Maximum value of SAR (measured) = 12.051 mW/g

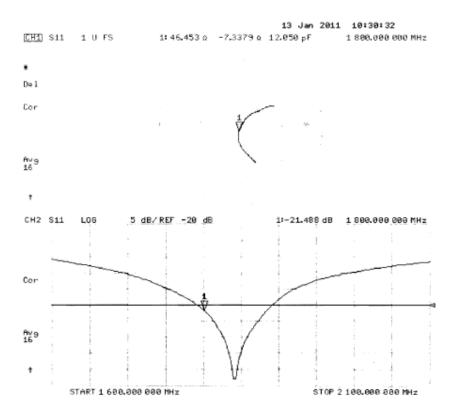


0 dB = 12.050 mW/g

Certificate No: D1800V2-2d020_Jan11

Testing Services™	Appendix D for the BlackB SAR Report	serry® Smartphone Mod	el RDD71UW/RDC	C71UW	Page 24 (36)
Author Data	Dates of Test	Test Report No	FCC ID:	IC ID	
Andrew Becker	Apr 13 – July 11, 2011	RTS-2579-1106-34A	L6ARDC70UW	2503A-R	DC70UW

Impedance Measurement Plot for Head TSL





Document

$\label{lem:lem:model} \textbf{Appendix D for the BlackBerry} \& \textbf{Smartphone Model RDD71UW/RDC71UW SAR Report}$

Page **25(36)**

Author Data
Andrew Becker

Dates of Test

Apr 13 – July 11, 2011

Test Report No RTS-2579-1106-34A

\ T

FCC ID:

L6ARDC70UW

1C ID 2503A-RDC70UW

Calibration Laboratory of Schmid & Partner Engineering AG Zeughausstrasse 43, 8004 Zurich, Switzerland





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RTS (RIM Testing Services)

Carliforn No. D1900V2-545 Jap 11

Accreditation No.: SCS 108

ALIBRATION	ERTIFICATE	The state of the s	A STATE OF THE STA
Dbject	D1900V2 - SN: 5	45 Committee on Applications	
Calibration procedure(s)	QA CAL-05.v8 Calibration proce	dure for dipole validation kits	
Calibration date:	January 13, 2011	ke Rejus gan dan persebagai kecamatan dan Persebagai kecamatan dan Persebagai kecamatan dan Persebagai kecamatan Rejusahan persebagai kecamatan dan Persebagai kecamatan dan Persebagai kecamatan dan Persebagai kecamatan dan	
The measurements and the unce	ertainties with confidence p	ional standards, which realize the physical un robability are given on the following pages an ry facility: environment temperature (22 ± 3)%	d are part of the certificate.
Calibration Equipment used (M&	TE critical for calibration)		
Primary Standards	ID#	Cal Date (Certificate No.)	Scheduled Calibration
ower meter EPM-442A	GB37480704	06-Oct-10 (No. 217-01266)	Oct-11
ower sensor HP 8481A	US37292783	06-Oct-10 (No. 217-01266)	Oct-11
eference 20 dB Attenuator	SN: 5086 (20g)	30-Mar-10 (No. 217-01158)	Mar-11
o.u.o. ue ze ez rineriame.		20 14 10 (N - 217 01100)	Mar-11
	SN: 5047.2 / 06327	30-Mar-10 (No. 217-01162)	Mar-11
ype-N mismatch combination	SN: 5047.2 / 06327 SN: 3205	30-Mar-10 (No. ES3-3205_Apr10)	Apr-11
ype-N mismatch combination Reference Probe ES3DV3			
ype-N mismatch combination leference Probe ES3DV3 IAE4	SN: 3205	30-Apr-10 (No. ES3-3205_Apr10) 10-Jun-10 (No. DAE4-601_Jun10)	Apr-11 Jun-11
ype-N mismatch combination Reference Probe ES3DV3 DAE4 Recondary Standards	SN: 3205 SN: 601	30-Apr-10 (No. ES3-3205_Apr10)	Apr-11
Type-N mismatch combination Reference Probe ES3DV3 DAE4 Secondary Standards Power sensor HP 8481A	SN: 3205 SN: 601 ID#	30-Apr-10 (No. ES3-3205_Apr10) 10-Jun-10 (No. DAE4-601_Jun10) Check Date (in house)	Apr-11 Jun-11 Scheduled Check
Type-N mismatch combination Reference Probe ES3DV3 DAE4 Secondary Standards Power sensor HP 8481A RF generator R&S SMT-06 Network Analyzer HP 8753E	SN: 3205 SN: 601 ID # MY41092317	30-Apr-10 (No. ES3-3205_Apr10) 10-Jun-10 (No. DAE4-601_Jun10) Check Date (in house) 18-Oct-02 (in house check Oct-09)	Apr-11 Jun-11 Scheduled Check In house check: Oct-11
Type-N mismatch combination Reference Probe ES3DV3 DAE4 Recondary Standards Power sensor HP 8481A RF generator R&S SMT-06	SN: 3205 SN: 601 ID # MY41092317 100005	30-Apr-10 (No. ES3-3205_Apr10) 10-Jun-10 (No. DAE4-601_Jun10) Check Date (in house) 18-Oct-02 (in house check Oct-09) 4-Aug-99 (in house check Oct-09)	Apr-11 Jun-11 Scheduled Check In house check: Oct-11 In house check: Oct-11
Type-N mismatch combination Reference Probe ES3DV3 DAE4 Recondary Standards Power sensor HP 8481A RF generator R&S SMT-06 Network Analyzer HP 8753E	SN: 3205 SN: 601 ID # MY41092317 100005 US37390585 S4206	30-Apr-10 (No. ES3-3205_Apr10) 10-Jun-10 (No. DAE4-601_Jun10) Check Date (in house) 18-Oct-02 (in house check Oct-09) 4-Aug-99 (in house check Oct-09) 18-Oct-01 (in house check Oct-10)	Apr-11 Jun-11 Scheduled Check In house check: Oct-11 In house check: Oct-11 In house check: Oct-11
Type-N mismatch combination Reference Probe ES3DV3 DAE4 Secondary Standards Power sensor HP 8481A RF generator R&S SMT-06	SN: 3205 SN: 601 ID # MY41092317 100005 US37390585 S4206 Name	30-Apr-10 (No. ES3-3205_Apr10) 10-Jun-10 (No. DAE4-601_Jun10) Check Date (in house) 18-Oct-02 (in house check Oct-09) 4-Aug-99 (in house check Oct-09) 18-Oct-01 (in house check Oct-10) Function Laboratory Technician	Apr-11 Jun-11 Scheduled Check In house check: Oct-11 In house check: Oct-11 In house check: Oct-11

Certificate No: D1900V2-545_Jan11

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Appendix D for the BlackBerry® Smartphone Model RDD71UW/RDC71UW **SAR Report**

26(36)

Author Data **Andrew Becker** Dates of Test

Apr 13 – July 11, 2011

Test Report No RTS-2579-1106-34A FCC ID: L6ARDC70UW

С

IC ID

2503A-RDC70UW

Calibration Laboratory of

Schmid & Partner Engineering AG Zeughausstrasse 43, 8004 Zurich, Switzerland





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Swiss Calibration Service

Accreditation No.: SCS 108

Accredited by the Swiss Accreditation Service (SAS)

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Glossary:

TSL

tissue simulating liquid

ConvF

sensitivity in TSL / NORM x,y,z

N/A

not applicable or not measured

Calibration is Performed According to the Following Standards:

- a) IEEE Std 1528-2003, "IEEE Recommended Practice for Determining the Peak Spatial-Averaged Specific Absorption Rate (SAR) in the Human Head from Wireless Communications Devices: Measurement Techniques", December 2003
- b) IEC 62209-1, "Procedure to measure the Specific Absorption Rate (SAR) for hand-held devices used in close proximity to the ear (frequency range of 300 MHz to 3 GHz)", February 2005
- Federal Communications Commission Office of Engineering & Technology (FCC OET). "Evaluating Compliance with FCC Guidelines for Human Exposure to Radiofrequency Electromagnetic Fields; Additional Information for Evaluating Compliance of Mobile and Portable Devices with FCC Limits for Human Exposure to Radiofrequency Emissions", Supplement C (Edition 01-01) to Bulletin 65

Additional Documentation:

d) DASY4/5 System Handbook

Methods Applied and Interpretation of Parameters:

- Measurement Conditions: Further details are available from the Validation Report at the end of the certificate. All figures stated in the certificate are valid at the frequency indicated.
- Antenna Parameters with TSL: The dipole is mounted with the spacer to position its feed point exactly below the center marking of the flat phantom section, with the arms oriented parallel to the body axis.
- Feed Point Impedance and Return Loss: These parameters are measured with the dipole positioned under the liquid filled phantom. The impedance stated is transformed from the measurement at the SMA connector to the feed point. The Return Loss ensures low reflected power. No uncertainty required.
- Electrical Delay: One-way delay between the SMA connector and the antenna feed point, No uncertainty required.
- SAR measured: SAR measured at the stated antenna input power.
- SAR normalized: SAR as measured, normalized to an input power of 1 W at the antenna connector.
- SAR for nominal TSL parameters: The measured TSL parameters are used to calculate the nominal SAR result.

Certificate No: D1900V2-545_Jan11

Page 2 of 6



Measurement Conditions

DASY system configuration, as far as not given on page 1.

DASY Version	DASY5	V52.6
Extrapolation	Advanced Extrapolation	
Phantom	Modular Flat Phantom V5.0	
Distance Dipole Center - TSL	10 mm	with Spacer
Zoom Scan Resolution	dx, dy, dz = 5 mm	
Frequency	1900 MHz ± 1 MHz	

Head TSL parameters

The following parameters and calculations were applied.

	Temperature	Permittivity	Conductivity
Nominal Head TSL parameters	22.0 °C	40.0	1.40 mho/m
Measured Head TSL parameters	(22.0 ± 0.2) °C	38.5 ± 6 %	1.43 mho/m ± 6 %
Head TSL temperature during test	(21.2 ± 0.2) °C		

SAR result with Head TSL

SAR averaged over 1 cm ³ (1 g) of Head TSL	Condition	
SAR measured	250 mW input power	10.2 mW / g
SAR normalized	normalized to 1W	40.8 mW / g
SAR for nominal Head TSL parameters	normalized to 1W	40.0 mW /g ± 17.0 % (k=2)

SAR averaged over 10 cm ³ (10 g) of Head TSL	condition	
SAR measured	250 mW input power	5.26 mW / g
SAR normalized	normalized to 1W	21.0 mW / g
SAR for nominal Head TSL parameters	normalized to 1W	20.8 mW /g ± 16.5 % (k=2)

Certificate No: D1900V2-545_Jan11



Appendix

Antenna Parameters with Head TSL

Impedance, transformed to feed point	50.8 Ω + 1.8 jΩ
Return Loss	- 34.4 dB

General Antenna Parameters and Design

Electrical Delay (one direction)	1.199 ns

After long term use with 100W radiated power, only a slight warming of the dipole near the feedpoint can be measured.

The dipole is made of standard semirigid coaxial cable. The center conductor of the feeding line is directly connected to the second arm of the dipole. The antenna is therefore short-circuited for DC-signals.

No excessive force must be applied to the dipole arms, because they might bend or the soldered connections near the feedpoint may be damaged.

Additional EUT Data

Manufactured by	SPEAG
Manufactured on	November 15, 2001



DASY5 Validation Report for Head TSL

Date/Time: 13.01.2011 14:52:49

Test Laboratory: SPEAG, Zurich, Switzerland

DUT: Dipole 1900 MHz; Type: D1900V2; Serial: D1900V2 - SN:545

Communication System: CW; Frequency: 1900 MHz; Duty Cycle: 1:1

Medium: HSL U12 BB

Medium parameters used: f = 1900 MHz; $\sigma = 1.43 \text{ mho/m}$; $\varepsilon_r = 38.6$; $\rho = 1000 \text{ kg/m}^3$

Phantom section: Flat Section

Measurement Standard: DASY5 (IEEE/IEC/ANSI C63.19-2007)

DASY5 Configuration:

Probe: ES3DV3 - SN3205; ConvF(5.09, 5.09, 5.09); Calibrated: 30.04.2010

Sensor-Surface: 3mm (Mechanical Surface Detection)

Electronics: DAE4 Sn601; Calibrated: 10.06.2010

Phantom: Flat Phantom 5.0 (front); Type: QD000P50AA; Serial: 1001

Measurement SW: DASY52, V52.6.1 Build (408)

Postprocessing SW: SEMCAD X, V14.4.2 Build (2595)

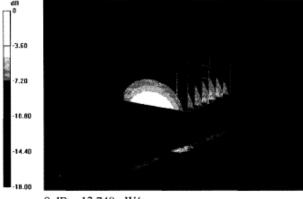
Pin=250 mW /d=10mm, dist=3.0mm (ES-Probe)/Zoom Scan (7x7x7) /Cube 0: Measurement

grid: dx=5mm, dy=5mm, dz=5mm

Reference Value = 98.053 V/m; Power Drift = 0.03 dB

Peak SAR (extrapolated) = 18.648 W/kg

SAR(1 g) = 10.2 mW/g; SAR(10 g) = 5.26 mW/gMaximum value of SAR (measured) = 12.743 mW/g

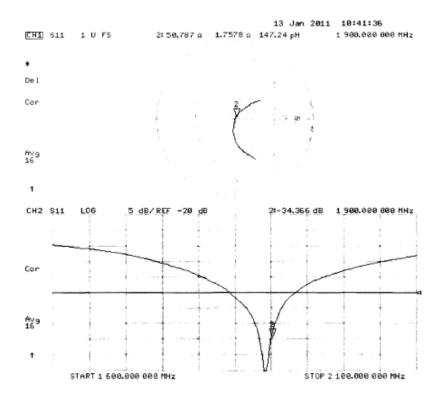


0 dB = 12.740 mW/g

Certificate No: D1900V2-545_Jan11

Testing Services™	Appendix D for the BlackB SAR Report	Berry® Smartphone Mod	el RDD71UW/RDC	C71UW	Page 30(36)
Author Data	Dates of Test	Test Report No	FCC ID:	IC ID	
Andrew Becker	Apr 13 – July 11, 2011	RTS-2579-1106-34A	L6ARDC70UW	2503A-R	DC70UW

Impedance Measurement Plot for Head TSL





Document

$\label{lem:lem:model} \textbf{Appendix D for the BlackBerry} \& \textbf{Smartphone Model RDD71UW/RDC71UW SAR Report}$

Page **31(36)**

Author Data
Andrew Becker

Dates of Test **Apr 13 – July 11, 2011**

Test Report No RTS-2579-1106-34A

FCC ID: L6ARDC70UW

2503A-RDC70UW

Calibration Laboratory of Schmid & Partner Engineering AG Zeughausstrasse 43, 8004 Zurich, Switzerland





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Client

RTS (RIM Testing Services)

Certificate No: D2450V2-747 Nov09

Accreditation No.: SCS 108

Client RTS (RIM Testi	ng Services)	Certific	ate No: D2450V2-747_NOV09	
CALIBRATION C	ERTIFICATE			
Object	D2450V2 - SN: 7	47,	1. 1. 4. 4. 4. 4. 6. 6.	
Calibration procedure(s)	QA CAL-05,v7 Calibration proce	dure for dipole validation kits		
Calibration date:	November 11, 20	09 11 11 14 F 11 1 1 1 1 1 1 1 1 1 1 1 1 1		
The measurements and the unce	rtainties with confidence p	onal standards, which realize the physi robability are given on the following par y facility: environment temperature (22	ges and are part of the certificate.	
Calibration Equipment used (M&T	E critical for calibration)			
Primary Standards	ID#	Cal Date (Certificate No.)	Scheduled Calibration	
Power meter EPM-442A	GB37480704	06-Oct-09 (No. 217-01086)	Oct-10	
Power sensor HP 8481A	US37292783	06-Oct-09 (No. 217-01086)	Oct-10	
Reference 20 dB Attenuator	SN: 5086 (20g)	31-Mar-09 (No. 217-01025)	Mar-10	
Type-N mismatch combination	SN: 5047.2 / 06327	31-Mar-09 (No. 217-01029)	Mar-10	
Reference Probe ES3DV3	SN: 3205	26-Jun-09 (No. ES3-3205_Jun09)	Jun-10	
DAE4	SN: 601	07-Mar-09 (No. DAE4-601_Mar09)	Mar-10	
Secondary Standards	ID#	Check Date (in house)	Scheduled Check	
Power sensor HP 8481A	MY41092317	18-Oct-02 (in house check Oct-09)	In house check: Oct-11	
RF generator R&S SMT-06	100005	4-Aug-99 (in house check Oct-09)	In house check: Oct-11	
Network Analyzer HP 8753E	US37390685 S4206	18-Oct-01 (in house check Oct-09)	In house check: Oct-10	
	Name	Function	Signature	
Calibrated by:	Mike Medi	Laboratory Technician	it. Deiv	
Approved by:	Kalja Pokovio	Technical Manager	S. IJ	
			Issued: November 16, 2009	

Certificate No: D2450V2-747_Nov09

Page 1 of 6



Appendix D for the BlackBerry® Smartphone Model RDD71UW/RDC71UW **SAR Report**

32(36)

Author Data Andrew Becker Dates of Test Apr 13 – July 11, 2011

Test Report No RTS-2579-1106-34A FCC ID: L6ARDC70UW

IC ID 2503A-RDC70UW

Calibration Laboratory of





Schweizerischer Kalibrierdienst

Service suisse d'étalonnage С

Servizio svizzero di taratura s Swiss Calibration Service

Accreditation No.: SCS 108

Schmid & Partner Engineering AG Zeughausstrasse 43, 8004 Zurich, Switzerland

Accredited by the Swiss Accreditation Service (SAS)

The Swiss Accreditation Service is one of the signatories to the EA Multilateral Agreement for the recognition of calibration certificates

Glossary:

TSL tissue simulating liquid

ConvF sensitivity in TSL / NORM x,y,z N/A not applicable or not measured

Calibration is Performed According to the Following Standards:

- a) IEEE Std 1528-2003, "IEEE Recommended Practice for Determining the Peak Spatial-Averaged Specific Absorption Rate (SAR) in the Human Head from Wireless Communications Devices: Measurement Techniques", December 2003
- b) IEC 62209-1, "Procedure to measure the Specific Absorption Rate (SAR) for hand-held devices used in close proximity to the ear (frequency range of 300 MHz to 3 GHz)", February 2005
- c) Federal Communications Commission Office of Engineering & Technology (FCC OET), "Evaluating Compliance with FCC Guidelines for Human Exposure to Radiofrequency Electromagnetic Fields; Additional Information for Evaluating Compliance of Mobile and Portable Devices with FCC Limits for Human Exposure to Radiofrequency Emissions", Supplement C (Edition 01-01) to Bulletin 65

Additional Documentation:

d) DASY4/5 System Handbook

Methods Applied and Interpretation of Parameters:

- Measurement Conditions: Further details are available from the Validation Report at the end of the certificate. All figures stated in the certificate are valid at the frequency indicated.
- Antenna Parameters with TSL: The dipole is mounted with the spacer to position its feed point exactly below the center marking of the flat phantom section, with the arms oriented parallel to the body axis.
- Feed Point Impedance and Return Loss: These parameters are measured with the dipole positioned under the liquid filled phantom. The impedance stated is transformed from the measurement at the SMA connector to the feed point. The Return Loss ensures low reflected power. No uncertainty required.
- Electrical Delay: One-way delay between the SMA connector and the antenna feed point. No uncertainty required.
- SAR measured: SAR measured at the stated antenna input power.
- SAR normalized: SAR as measured, normalized to an input power of 1 W at the antenna connector.
- SAR for nominal TSL parameters: The measured TSL parameters are used to calculate the nominal SAR result.

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Testing Services™	Appendix D for the BlackE SAR Report	Berry® Smartphone Mod	lel RDD71UW/RD0	C71UW	Page 33(36)
Author Data	Dates of Test	Test Report No	FCC ID:	IC ID	
Andrew Becker	Apr 13 – July 11, 2011	RTS-2579-1106-34A	L6ARDC70UW	2503A-R	DC70UW

Measurement Conditions

DASY system configuration, as far as not given on page 1.

DASY Version	DASY5	V5.2
Extrapolation	Advanced Extrapolation	
Phantom	Modular Flat Phantom V4.9	
Distance Dipole Center - TSL	10 mm	with Spacer
Zoom Scan Resolution	dx, dy, dz = 5 mm	
Frequency	2450 MHz ± 1 MHz	

Head TSL parameters

The following parameters and calculations were applied.

	Temperature	Permittivity	Conductivity
Nominal Head TSL parameters	22.0 °C	39.2	1.80 mho/m
Measured Head TSL parameters	(22.0 ± 0.2) °C	39.1 ± 6 %	1.78 mho/m ± 6 %
Head TSL temperature during test	(21.3 ± 0.2) °C		

SAR result with Head TSL

SAR averaged over 1 cm3 (1 g) of Head TSL	Condition	
SAR measured	250 mW input power	13.3 mW / g
SAR normalized	normalized to 1W	53.2 mW / g
SAR for nominal Head TSL parameters	normalized to 1W	53.4 mW /g ± 17.0 % (k=2)

SAR averaged over 10 cm ³ (10 g) of Head TSL	condition	
SAR measured	250 mW input power	6.23 mW / g
SAR normalized	normalized to 1W	24.9 mW / g
SAR for nominal Head TSL parameters	normalized to 1W	24.9 mW /g ± 16.5 % (k=2)

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Appendix

Antenna Parameters with Head TSL

Impedance, transformed to feed point	$51.9 \Omega + 0.9 j\Omega$
Return Loss	- 33.9 dB

General Antenna Parameters and Design

ı	Electrical Delay (one direction)	1.161 ns

After long term use with 100W radiated power, only a slight warming of the dipole near the feedpoint can be measured.

The dipole is made of standard semirigid coaxial cable. The center conductor of the feeding line is directly connected to the second arm of the dipole. The antenna is therefore short-circuited for DC-signals.

No excessive force must be applied to the dipole arms, because they might bend or the soldered connections near the feedpoint may be damaged.

Additional EUT Data

Manufactured by	SPEAG		
Manufactured on	December 01, 2003		

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Testing Services™	Appendix D for the BlackE SAR Report	Berry® Smartphone Mod	lel RDD71UW/RD0	C71UW	Page 35(36)
Author Data	Dates of Test	Test Report No	FCC ID:	IC ID	D.C.FOLINY
Andrew Becker	Apr 13 – July 11, 2011	RTS-2579-1106-34A	L6ARDC70UW	2503A-K	DC70UW

DASY5 Validation Report for Head TSL

Date/Time: 11.11.2009 15:04:10

Test Laboratory: SPEAG, Zurich, Switzerland

DUT: Dipole 2450 MHz; Type: D2450V2; Serial: D2450V2 - SN:747

Communication System: CW; Frequency: 2450 MHz; Duty Cycle: 1:1

Medium: HSL U11 BB

Medium parameters used: f = 2450 MHz; $\sigma = 1.79 \text{ mho/m}$; $\varepsilon_r = 39.2$; $\rho = 1000 \text{ kg/m}^3$

Phantom section: Flat Section

Measurement Standard: DASY5 (IEEE/IEC/ANSI C63.19-2007)

DASY5 Configuration:

Probe: ES3DV3 - SN3205; ConvF(4.53, 4.53, 4.53); Calibrated: 26.06.2009

Sensor-Surface: 3mm (Mechanical Surface Detection)
 Electronics: DAE4 Sn601; Calibrated: 07.03.2009

Phantom: Flat Phantom 5.0 (front); Type: QD000P50AA; Serial: 1001

Measurement SW: DASY5, V5.2 Build 157; SEMCAD X Version 14.0 Build 57

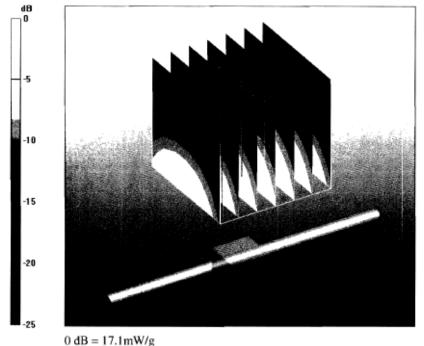
Head/d=10mm, Pin=250 mW, dist=3.0mm (ES-Probe)/Zoom Scan (7x7x7) (7x7x7)/Cube 0:

Measurement grid: dx=5mm, dy=5mm, dz=5mm

Reference Value = 101.3 V/m; Power Drift = 0.067 dB

Peak SAR (extrapolated) = 27 W/kg

SAR(1 g) = 13.3 mW/g; SAR(10 g) = 6.23 mW/gMaximum value of SAR (measured) = 17.1 mW/g



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Testing Services™	Appendix D for the BlackBerry® Smartphone Model RDD71UW/RDC71UW SAR Report				Page 36(36)
Author Data	Dates of Test	Test Report No	FCC ID:	IC ID	
Andrew Becker	Apr 13 – July 11, 2011	RTS-2579-1106-34A	L6ARDC70UW	2503A-R	DC70UW

Impedance Measurement Plot for Head TSL

